Application/Control No. O9/987,385 Reexamination HAYASHI ET AL. Examiner Mark Ruthkosky Applicant(s)/Patent Under Reexamination HAYASHI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification		
	Α	US-6132900	10-2000	Yoshizawa	429/185		
	В	US-5586993	12-1996	Saito	29/623.2		
	U	US-			_		
	D	US-					
	Е	US-					
	F	US-					
	G	US-					
	Ι	US-					
	_	US-					
	J	US-					
	К	US-			· ··		
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FOREIGN PATENT DOCUMENTS							

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	JP 11-167909	06-1999	JPO	Yoshitaka	H01M 2/04
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NON-PATENT DOCUMENTS

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